

Notice of References Cited	Application/Control No. 10/807,103		Applicant(s)/Patent Under Reexamination MATSUDA ET AL.	
	Examiner Jack Smith		Art Unit 1709	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,189,917	03-2007	Okada et al.	136/255
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2000-150934	03-2000	Japan	Nakajima et al.	HO1L 31/04
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	T. Minami, H. Nanto and S. Takata, "Highly conductive and transparent zinc oxide films prepared by rf magnetron sputtering under an applied external magnetic field", Applied Physics Letters 41, 958-960 (1982)
	V	K. Von Rottkay, M. Rubin, N. Ozer, "Optical Indices of Tin-Doped Indium Oxide and Tungsten Oxide Electrochromic Coatings", Mater. Res. Soc. Symp. Proc. 403, 551-556. (1995)
	W	R. A. Rabadanov, M. K. Guseikhanov, I. Sh. Aliev and S. A. Semiletov, "Properties of metal-zinc oxide contacts", Izvestiya Vysshikh Uchebnykh Zavedenii, Fizika, 6, 72-75 (1981)
	X	C. Agashe, O. Kluth, G. Schöpe, H. Siekmann, J. Hüpkes and B. Rech "Optimization Of The Electrical Properties Of Magnetron Sputtered Aluminium Doped Zinc Oxide Films For Opto-Electronic Applications" Proceedings of the 4th International Conference on Coatings on Glass : Braunschweig, Germany. - 2002. - S. 5

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	Examiner Jack Smith	Art Unit 1709	Page 2 of 2

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	G	US-			
	H	US-			
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	J	US-			
	K	US-			
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	M	US-			

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	M.A. Martinez, J. Herrero, M.T. Gutierrez, " Optimisation of indium tin oxide thin films for photovoltaic applications", Thin Solid Films 269, 80-84 (1995)
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.